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## Texas Instruments Enhanced Plastic Products Reliability Report

(Subject To Attached Disclaimers)

Device Type/Device Family: INA193AMDBVREP  
 Package Type: 5/DBV  
 Wafer Fabrication Facility: HIJI FAB (Hiji, Japan)  
 Assembly/Test Facility: Carsem M  
 Compiled: 04/11

### Biased Life Test

Test Method: JESD22-A108  
 Test Condition: 125°C / 1000 hours or equivalent  
 Sample Size: 6822  
 Rejects: 3  
 Activation Energy (eV): 0.5  
 Equivalent Device Hours: 1.12E+08  
 Failure Rate (FIT)\*: 37.26

\*Derated to +55°C with a 60% Confidence Level

### Package Related Tests

| <u>Description</u>            | <u>Condition</u>   | <u>Referenced Method</u>   | <u>Sample Size</u> | <u>Rejects</u> |               |
|-------------------------------|--|----------------------------|--------------------|----------------|---------------|
| Biased Humidity<br>or<br>HAST | 85°C / 85% / 1000 hours<br>or<br>130°C / 85% / 96 hours    | JESD22-A101<br>JESD22-A110 | 385                | 0              | *             |
| Autoclave                     | 121°C @ 2 atmospheres<br>absolute for 96 hours             | JESD22-A102                | 308                | 0              | *             |
| Temperature Cycle             | -65°C to +150°C non-biased<br>for 500 cycles or equivalent | JESD22-A104                | 392                | 0              | *             |
| High Temp Storage             | 150°C / 1,000 hours  | JESD22-A103-A              | 49                 | 0              | * (Also See E |

\* Preconditioning per JEDEC Std. 22, Method A112/A113

### Initial Product Qualification

The subject Enhanced Plastic device, device family, and/or package family have passed Texas Instruments product qualification as follows:

| <u>Description</u>                  | <u>Condition</u>  | <u>Referenced Method</u> | <u>Sample Size</u> |   |
|-------------------------------------|---|--------------------------|--------------------|---|
| Electrical Characterization         | TI Data Sheet   | N/A                      | 1 lot(s)/30 Units  |   |
| Electrostatic Discharge Sensitivity | HBM   | EIA/JESD22-A114          | 3 Units/voltage    |   |
|                                     | MM  | EIA/JESD22-A115          | 3 Units/voltage    |   |
|                                     | CDM   | JESD22-C101              | 3 Units/voltage    |   |
| Latch-up                            | Per Technology  | EIA/JESD78               | 6/0                |   |
| Physical Dimensions                 | TI Data Sheet   | EIA/JESD22- B100         | 15/0               |   |
| Thermal Impedance                   | Theta-JA on board                                       | EIA/JESD51               | Per Pin-Package    |   |
| Bias Life Test                      | 125°C / 1000 hours or equivalent                        | JESD22-A108              | 385/0              |   |
| Biased Humidity or HAST             | 85°C / 85% / 1000 hours                                 | JESD22-A101              | 385/0              | * |
|                                     | 130°C / 85% / 96 hours                                  | JESD22-A110              |                    |   |
| Autoclave                           | 121°C @ 2 atmospheres absolute for 96 hours             | JESD22-A102              | 308/0              | * |
| Temperature Cycle                   | -65°C to +150°C non-biased for 500 cycles or equivalent | JESD22-A104              | 392/0              | * |
| High Temp Storage                   | 150°C / 1,000 hours                                     | JESD22-A103-A            | 49/0               | * |
| Solder Heat                         | 260°C for 10 seconds                                    | JESD22-B106              | 15/0               |   |
| Solderability                       | Condition A (steam age for 8 hours)                     | ANSI/J-STD-002-92        | 66/0               |   |
| Bond Strength                       | -   | ASTM F-459               | 30/0               |   |
| Moisture Sensitivity                | Surface Mount Only                                      | J-STD-020-A              | LVL2-260           |   |

\* Preconditioning per JEDEC Std. 22, Method A112/A113

### Supplemental Device Characteristics

|   |  |
|---|--|
| Master Die: JINA1820CAPZ                                | Assembly Site: Carsem M                    |
| Wafer Fab: HIJI FAB (Hiji, Japan)                       | Pin/Package Type: 5/DBV                    |
| Fab Process: LBC-SOI                                    | Lead Composition: Cu                       |
| Fab Technology: BiCMOS                                  | Lead Finish: NiPdAu                        |
| Die Revision: C   | Mount Compound: ABLESTIK 8290              |
| Passivation: 6kA SiO <sub>2</sub> / 11kA +/- 1kA of SIN | Bond: Au/1.0 mil                           |
| Metal 1: 300A TiW / 4.6kA AlCu(.5%) / 3                 | Mold Compound: HITACHI CEL9220HF13         |
| Metal 2: 3kA TiW / 6kA AlCu(.5%) / 300A                 | Die Thickness: 25 Mils BG @ CAR to 9.5Mils |

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Enterprise Qualification Report)

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|                               |  |
|-------------------------------|--|
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